

13. TEST SETUP PHOTOGRAPHS

FCC ID: A3LSMN950F		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1705180172-13.A3L	Test Dates: 06/16/2017	DUT Type: Portable Handset	Page 49 of 51	

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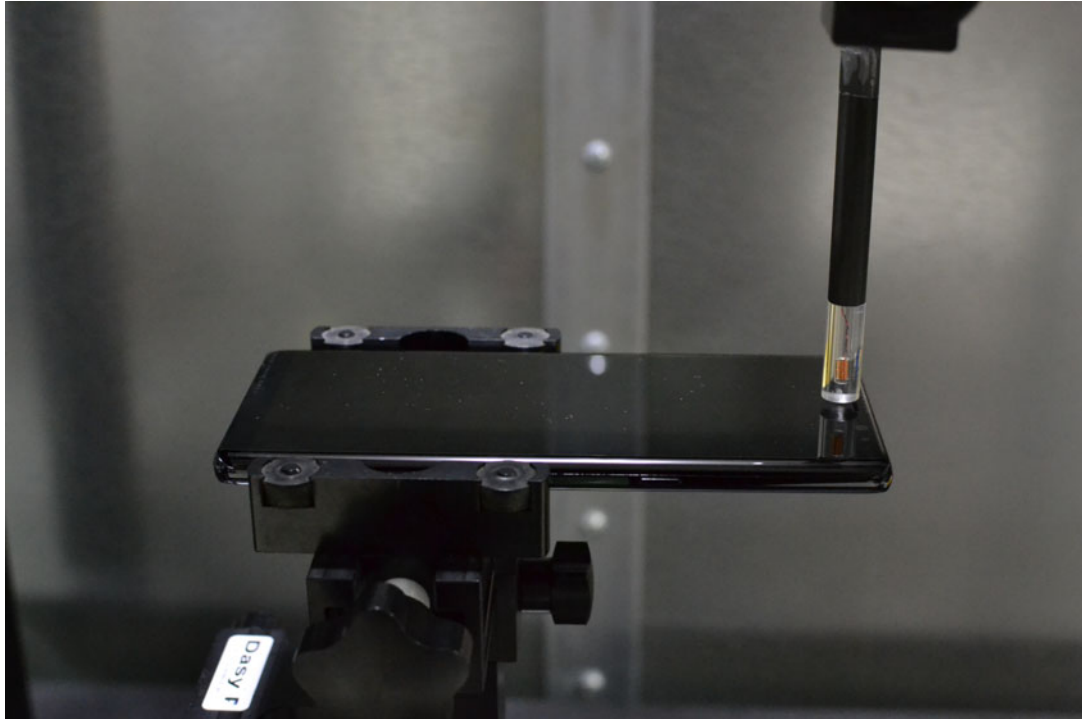


Figure 13-1
Test Setup for Wireless Device

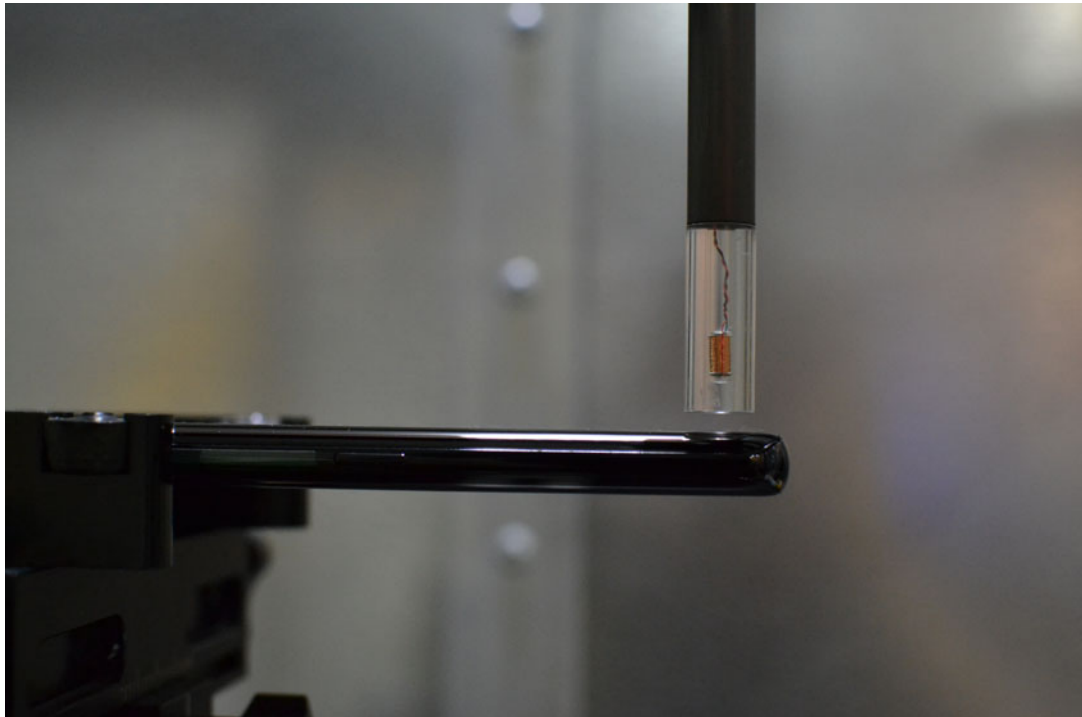


Figure 13-2
Test Setup for Wireless Device

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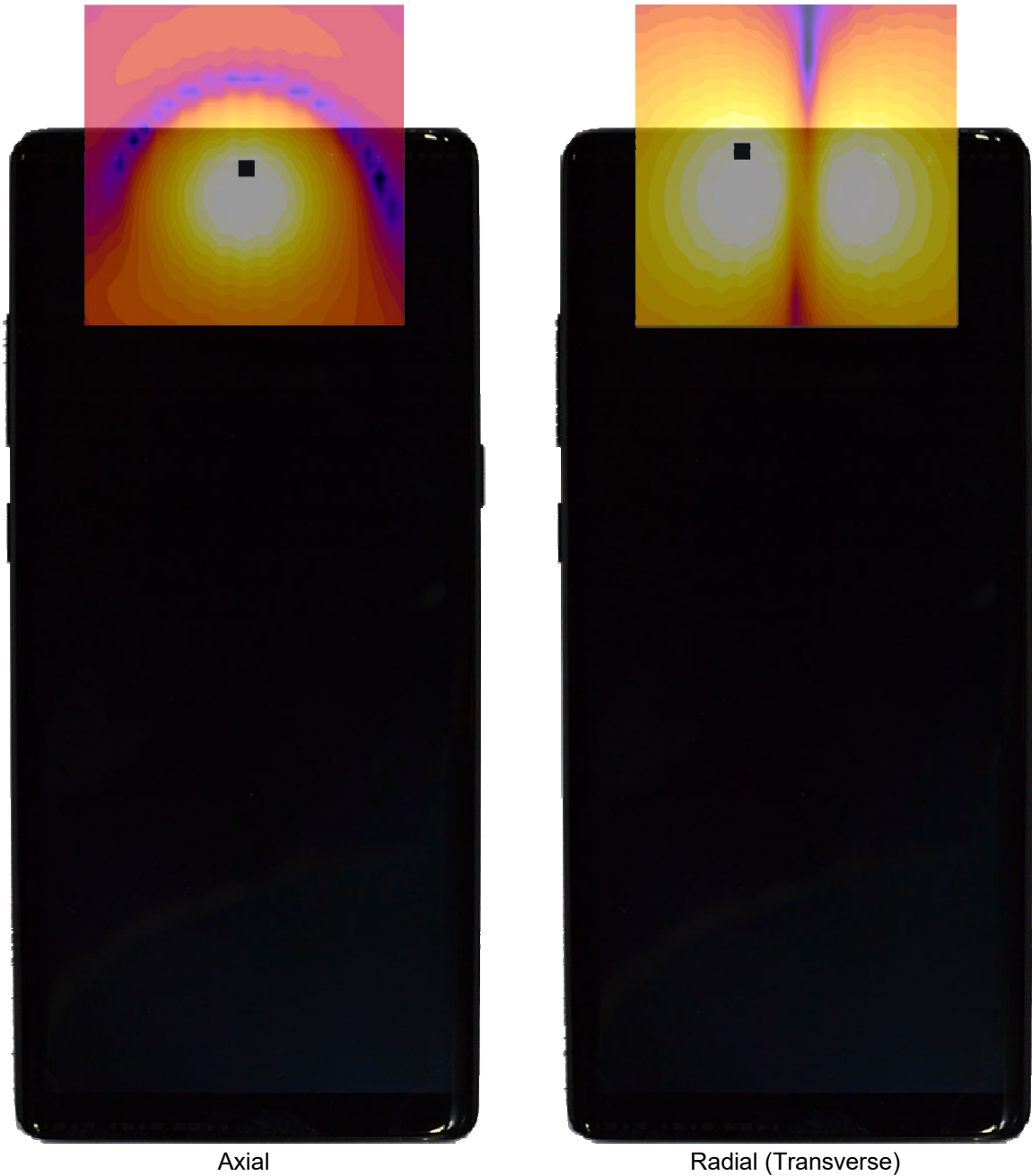


Figure 13-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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